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# Exciton tuning in monolayer WSe<sub>2</sub> via substrate induced electron doping†

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We report large exciton tuning in WSe<sub>2</sub> monolayers via substrate induced non-degenerate doping. We observe a redshift of ~62 meV for the A exciton together with a 1–2 orders of magnitude photoluminescence (PL) quenching when the monolayer WSe<sub>2</sub> is brought in contact with highly oriented pyrolytic graphite (HOPG) compared to dielectric substrates such as hBN and SiO<sub>2</sub>. As the evidence of doping from HOPG to WSe<sub>2</sub>, a drastic increase of the intensity ratio of trions to neutral excitons was observed. Using a systematic PL and Kelvin probe force microscopy (KPFM) investigation on WSe<sub>2</sub>/HOPG, WSe<sub>2</sub>/hBN, and WSe<sub>2</sub>/graphene, we conclude that this unique excitonic behavior is induced by electron doping from the substrate. Our results propose a simple yet efficient way for exciton tuning in monolayer WSe<sub>2</sub>, which plays a central role in the fundamental understanding and further device development.

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## 1 Introduction

Beyond graphene,<sup>1</sup> transition metal dichalcogenides (TMDCs) are currently at the center of 2D materials research, owing to their extraordinary optical, electrical, thermal, and mechanical properties,<sup>2–5</sup> and, most importantly, to the unique indirect-to-direct-bandgap transition when the material is thinned from bulk to monolayer.<sup>6,7</sup> The direct bandgap nature of monolayer TMDCs makes them promising materials for next generation optoelectronic devices.<sup>8–10</sup> Exciton tuning and bandgap engineering become extremely important in this case, as they build the basis for fundamental research including but not limited to exciton–polariton, many-body physics, and optical selection rules.<sup>11–15</sup> Moreover, they are the key for sufficiently widening the application field and devices towards 2D photonics and optoelectronics.<sup>16,17</sup> Different approaches of exciton tuning and bandgap engineering have been reported such as changing the dielectric environment, mechanical straining, doping, alloying,

injecting plasmonic hot electrons, and manipulating the carrier concentration via an external electric field.<sup>18–25</sup>

In this work, we report tuning the exciton energy in monolayer WSe<sub>2</sub> via substrate induced non-degenerate electron doping. We observe an ~62 meV redshift for the A exciton (from ~1.65 eV to ~1.59 eV) together with a few orders of magnitude photoluminescence (PL) quenching when the monolayer WSe<sub>2</sub> is brought in contact with HOPG compared to the WSe<sub>2</sub> excitonic feature on dielectric substrates such as hBN, SiO<sub>2</sub>, and polydimethylsiloxane (PDMS), which has been measured and reported in our previous work.<sup>26</sup> As a by-product, a drastic increase of the intensity ratio of trions to neutral excitons up to 5.5 times was observed, which is a characteristic of electron doping in TMDC monolayers. To understand this unique behavior, we employed a systematic PL and Kelvin probe force microscopy (KPFM) investigation on different TMDC/substrate combinations, namely WSe<sub>2</sub>/HOPG, WSe<sub>2</sub>/graphene, and WSe<sub>2</sub>/hBN as a reference. Surprisingly, we were only able to observe such a pronounced redshift when WSe<sub>2</sub> was in contact with HOPG but not with graphene. The KPFM measurements provide different contact potential difference (CPD) values when comparing WSe<sub>2</sub>/HOPG to WSe<sub>2</sub>/graphene and WSe<sub>2</sub>/hBN. This indicates different Fermi level positions and different carrier concentrations in WSe<sub>2</sub>. The PL quenching, redshift, increase of the intensity ratio of trions to neutral excitons, and different CPD values all conclusively point towards electrons from the HOPG substrate injected to WSe<sub>2</sub> and leading to bandgap renormalization and thus the tuning of exciton energy. Our work explains the unique behavior of monolayer WSe<sub>2</sub>/

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HOPG and demonstrates a simple yet efficient method, which enables the exciton energy in monolayer WSe<sub>2</sub> to be tuned by ~62 meV. This is essential for fundamental studies and the development of devices such as photodetectors, excitonic LEDs, and coupling with plasmonics.<sup>10,27–30</sup>

## 2 Materials and methods

### 2.1 Sample preparation

Few layer hBN (from 2D semiconductors), graphene (from NGS Naturgraphit), and monolayer WSe<sub>2</sub> (from HQ graphene) are mechanically exfoliated from their bulk crystals *via* Nitto tape onto a PDMS stamp and then transferred bottom-to-top onto the HOPG substrate following a deterministic all-dry transfer technique.<sup>31,32</sup> All materials on PDMS are first characterized by PL and Raman prior to transfer. HOPG is cleaved before transfer to ensure a fresh surface. After transfer, the samples are annealed in a nitrogen atmosphere at 150 °C for 2 hours to optimize the contact between flakes and ensure a clean surface. The detailed process used for sample fabrication is shown in Fig. 1S and 2S.†

### 2.2 Optical spectroscopy

PL measurements are performed using a Horiba Xplora Plus equipped with a 100×, 0.9 NA objective, a spectrometer comprising a 600 l mm<sup>-1</sup> grating, and an electron-multiplying CCD (EMCCD). A DPSS 532 nm CW laser source was used for excitation. The laser power is ~100 μW measured under the objective for PL measurements if not specified differently. The

setup is equipped with a Märzhäuser motorized xyz stage with a 100 nm step size precision for PL mapping.

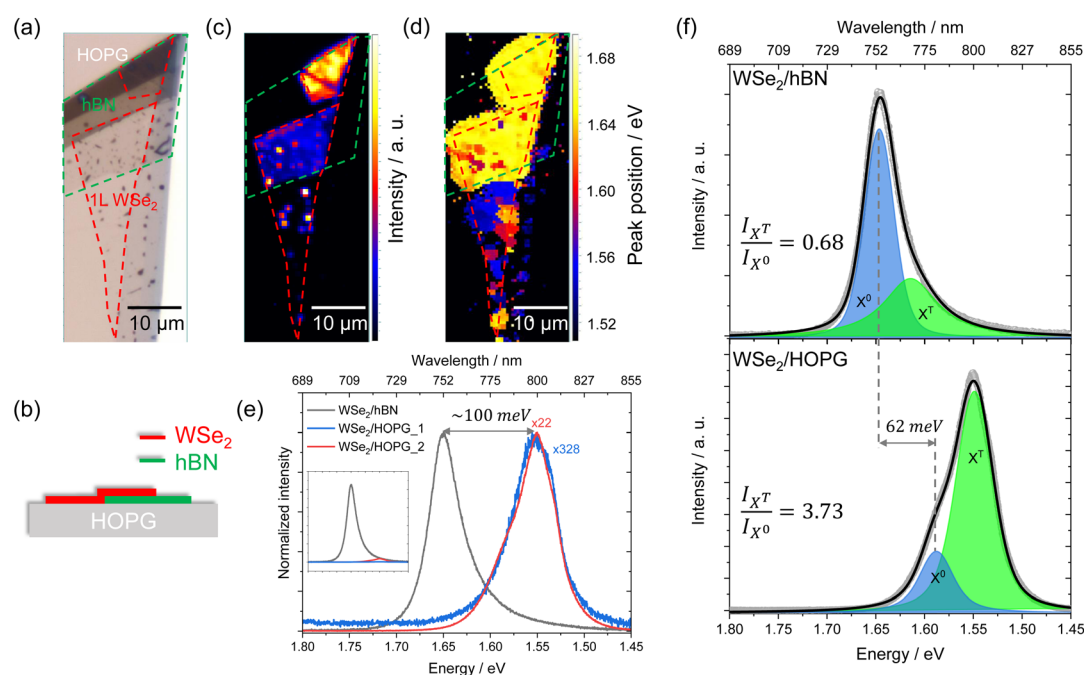
Raman spectra are acquired using a Horiba LabRAM HR spectrometer with a 100×, 0.9 NA objective, a 2400 l mm<sup>-1</sup> grating, and a liquid nitrogen cooled Symphony CCD detector. A solid-state 514.7 nm laser is used for excitation with a laser power of ~100 μW measured under the objective. We choose a confocal pinhole of 50 μm to reach a high spectral resolution of approximately 0.8 cm<sup>-1</sup>.

### 2.3 Kelvin probe force microscopy

We use an AIST-NT SmartSPM™ 1000 for KPFM measurements. The KPFM measurements are performed under ambient conditions with constant temperature and humidity. The NSG10 Pt coated tip is commercially available with a typical tip radius of ~35 nm.

## 3 Results and discussion

Fig. 1(a) and (b) display the optical microscopy image and the schematic cross-section of a WSe<sub>2</sub>/hBN/HOPG hetero-stack, respectively. The monolayer WSe<sub>2</sub> is transferred onto the hBN/HOPG hetero-stack in a way that it creates contacts with both few layer hBN and HOPG. According to the atomic force microscopy (AFM) measurement shown in Fig. 8S,† the top brown-colored hBN has a thickness of ~38.2 nm, and the middle part has a thickness of ~3.8 nm. We acquired a micro PL map on the sample with a step size of 0.5 μm. As shown in the intensity map in Fig. 1(c), the PL intensity of WSe<sub>2</sub> on thick hBN is higher than that on thin hBN because of interference



**Fig. 1** (a) Optical microscopy image and (b) schematic cross-section of the WSe<sub>2</sub>/hBN/HOPG hetero-stack. PL (c) intensity and (d) peak position map of the sample. (e) PL spectra of WSe<sub>2</sub>/hBN and WSe<sub>2</sub>/HOPG. For comparison, the PL intensity of WSe<sub>2</sub>/HOPG is normalized to that of WSe<sub>2</sub>/hBN. Inset: as-measured (not-normalized) PL spectra. (f) Fitted PL spectra of WSe<sub>2</sub>/hBN and WSe<sub>2</sub>/HOPG.



enhancement.<sup>33,34</sup> More importantly, comparing the PL intensity of WSe<sub>2</sub> on hBN and HOPG, one can clearly identify that a drastic decrease of PL intensity occurs on HOPG. Several mechanisms can cause the low PL quantum yield and thus lead to the decrease of PL intensity, such as high defect concentration, strong many-body effects, charge dissociation and charge transfer.<sup>34–37</sup> Since the samples investigated in this work are prepared by mechanical exfoliation from the same flake, we attribute the PL intensity decrease to charge dissociation or charge transfer. The few dots that still remain intense may correspond to bubbles or hydrocarbon contaminants at the interface, which can enhance the PL signal (more information about the influence of bubbles on the PL spectra can be found in Fig. 5S†).<sup>38–40</sup> Fig. 1(d) displays the peak position map indicating that the sample is clearly divided into two parts: WSe<sub>2</sub>/hBN with a peak position of  $\sim 1.65$  eV and WSe<sub>2</sub>/HOPG with a peak position of  $\sim 1.55$  eV.

The detailed spectra of WSe<sub>2</sub>/hBN and WSe<sub>2</sub>/HOPG are shown in Fig. 1(e). A strong PL quenching of 1–2 orders of magnitude is observed when WSe<sub>2</sub> is in contact with HOPG, which indicates charge dissociation through the junction or charge transfer between WSe<sub>2</sub> and HOPG.<sup>34,35</sup> Monolayer WSe<sub>2</sub> on hBN shows a characteristic PL at  $\sim 1.65$  eV, which is consistent with the literature values,<sup>26,41</sup> while the PL peak position of WSe<sub>2</sub>/HOPG shows a marked  $\sim 100$  meV redshift, which is much higher than the reported value caused by changing of the dielectric environment.<sup>18</sup> Besides the quenching and redshift, the PL line shape changes significantly. We thus deconvoluted the PL spectra into peaks corresponding to the radiative recombination of different exciton/trion species in monolayer WSe<sub>2</sub> (detailed fitting parameters can be found in the ESI†). As shown in Fig. 1(f), two peaks with a Voigt line shape were identified in the fitted spectra. The neutral exciton ( $X^0$ ) originates from the direct bandgap transition at the *K* point in the Brillouin zone and there is a charged exciton peak also known as trion  $X^T$ .<sup>41–44</sup> We also investigated the Stokes shift of monolayer WSe<sub>2</sub> as shown in Fig. 3S,† which is negligible with a value of  $\sim 2$  meV. It is therefore fair enough to consider the PL peak position as the exciton energy. The fitting result suggests

a 62 meV redshift of  $X^0$  and most interestingly, a drastic increase of the relative  $X^T$  intensity. The ratio of  $I_{X^T}/I_{X^0}$  increases from  $0.68 \pm 0.01$  on hBN to  $3.73 \pm 0.04$  on HOPG, which is strong evidence of a higher electron concentration in WSe<sub>2</sub> on HOPG than in WSe<sub>2</sub> on hBN.

Even though we propose that charge transfer and electron doping from HOPG to monolayer WSe<sub>2</sub> seem to be the most reasonable mechanism of PL quenching, redshift, and increasing intensity ratio of trions to neutral excitons, we still carefully examined whether they originate from the defect-bound localized states or strain due to lattice mismatch. Power dependent PL intensities of WSe<sub>2</sub>/hBN and WSe<sub>2</sub>/HOPG are displayed in Fig. 2(a). The PL intensity is obtained from the integrated area of the Voigt fitted  $X^0$  and  $X^T$  features. The PL intensity as a function of excitation laser power is then fitted by a power law:  $I \propto P^\alpha$ ,<sup>41,45</sup> where the extracted exponential factor  $\alpha_{X^0}^{\text{WSe}_2/\text{hBN}} = 0.75 \pm 0.02$ ,  $\alpha_{X^T}^{\text{WSe}_2/\text{hBN}} = 0.80 \pm 0.01$ ,  $\alpha_{X^0}^{\text{WSe}_2/\text{HOPG}} = 0.89 \pm 0.03$ , and  $\alpha_{X^T}^{\text{WSe}_2/\text{HOPG}} = 0.89 \pm 0.05$  for  $X^0$  and  $X^T$  on WSe<sub>2</sub>/hBN and WSe<sub>2</sub>/HOPG, respectively. The fitting results suggest a sublinear power dependence of the PL intensity for both  $X^0$  and  $X^T$  on WSe<sub>2</sub>/hBN and WSe<sub>2</sub>/HOPG and do not show any saturation phenomena at high laser power, which excludes the possibility of defects as the origin of the observed behavior.<sup>46</sup> Fig. 2(b) shows the high spectral resolution ( $\sim 0.8$  cm<sup>-1</sup>) Raman spectra of WSe<sub>2</sub>/hBN and WSe<sub>2</sub>/HOPG (only two spectra are shown in the main text for clarity, more spectra can be found in the ESI†). The most intense peak at  $\sim 250$  cm<sup>-1</sup> corresponds to the combination of the in-plane  $E_{2g}$  and out-of-plane  $A_{1g}$  vibrational modes, which are almost degenerate at the same frequency.<sup>26,47–49</sup> The feature at  $\sim 260$  cm<sup>-1</sup> is a second order peak caused by a double resonance effect involving the longitudinal acoustic phonon at the *M* point in the Brillouin zone assigned as  $2LA(M)$ .<sup>49,50</sup> The  $E_{2g}/A_{1g}$  mode is highly sensitive to the strain.<sup>51,52</sup> The fitted Raman spectra reveal a small  $0.15$  cm<sup>-1</sup> peak position difference, which indicates that strain is also small and cannot account for the huge redshift in PL.

KPFM is a powerful technique to obtain the local surface potential and Fermi level position in the nanoscale.<sup>34,53</sup> We

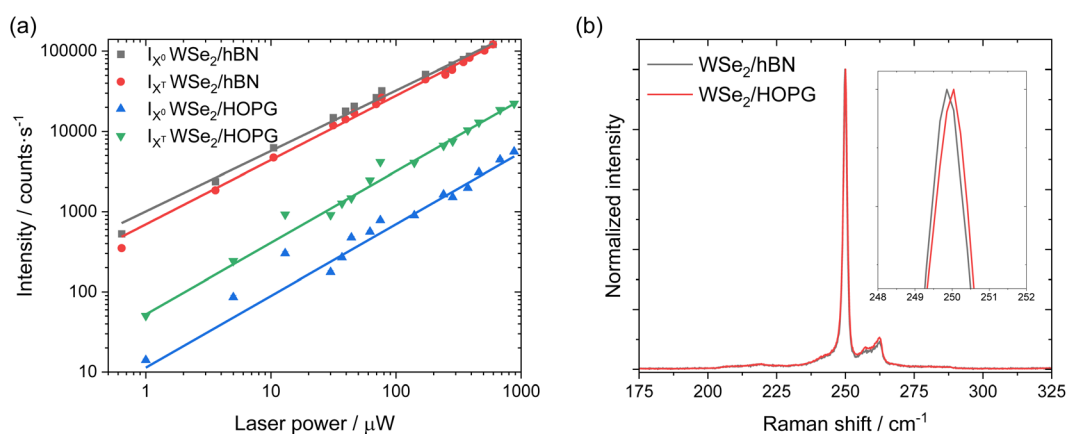


Fig. 2 (a) PL intensity as a function of excitation power for  $X^0$  and  $X^T$  emissions from WSe<sub>2</sub>/hBN and WSe<sub>2</sub>/HOPG. Solid lines are fits to a power law:  $I \propto P^\alpha$ . (b) High spectral resolution Raman spectra of WSe<sub>2</sub>/hBN and WSe<sub>2</sub>/HOPG. Inset is a zoom in at 248–252 cm<sup>-1</sup>.



therefore measured KPFM on the WSe<sub>2</sub>/hBN/HOPG hetero-stack to obtain further insight into the energy level alignment at the various interfaces. In the ideal case KPFM measures the contact potential difference (CPD) between the metallic AFM tip and the sample according to the relation:  $CPD = (\phi_{\text{sample}} - \phi_{\text{tip}})/e$ , where  $\phi_{\text{sample}}$  and  $\phi_{\text{tip}}$  are the work functions of the sample and the tip, and  $e$  is the elementary charge. KPFM does not give a quantitative, absolute value of the Fermi level position under ambient conditions, because the CPD value is known to be strongly influenced by the measurement environment, tip geometry, and parasitic effects such as capacitive coupling, as well as the chosen experimental parameters.<sup>54–57</sup> Nevertheless, it still qualitatively indicates the trend of the Fermi level position and material work functions.<sup>34,53,58,59</sup> The values of the energy levels discussed in the following paragraph are directly extracted from the KPFM measurements.

Fig. 3(a) shows the CPD map of WSe<sub>2</sub>/hBN/HOPG. Even though it is the same monolayer WSe<sub>2</sub> flake, one can clearly distinguish the high contrast between WSe<sub>2</sub> on hBN and WSe<sub>2</sub> on HOPG. The absolute work function of HOPG is determined

to be  $\phi_{\text{HOPG}} = 4.4$  eV by the ultraviolet photoelectron spectroscopy (UPS) measurement shown in Fig. 10S.† The electron affinity of monolayer WSe<sub>2</sub> is reported to be 3.7–3.9 eV.<sup>60,61</sup> We therefore calculate and draw the band diagrams of WSe<sub>2</sub> before (on hBN) and after (on HOPG) coming into contact with HOPG as shown in Fig. 3(b) and (c), respectively. The band diagrams reveal a decrease of the work function or increase of the Fermi level when WSe<sub>2</sub> is in contact with HOPG, which indicates a higher electron concentration in WSe<sub>2</sub> on HOPG than in WSe<sub>2</sub> on hBN. The high electron concentration in WSe<sub>2</sub>/HOPG can only originate from electron doping from HOPG to WSe<sub>2</sub>, which explains the PL quenching, redshift, and increasing intensity ratio of trions to neutral excitons shown in Fig. 1.

Apparently interfacing WSe<sub>2</sub> with HOPG results in efficient tuning of the exciton emission in a straightforward manner. Researchers also studied the combination of WSe<sub>2</sub> and graphene,<sup>18</sup> yet did not report similar results. This naturally leads to the question: do graphene and graphite lead to a different interaction when interfaced with WSe<sub>2</sub>? To answer this question, we prepared a hetero-stack of WSe<sub>2</sub>/graphene/hBN/HOPG

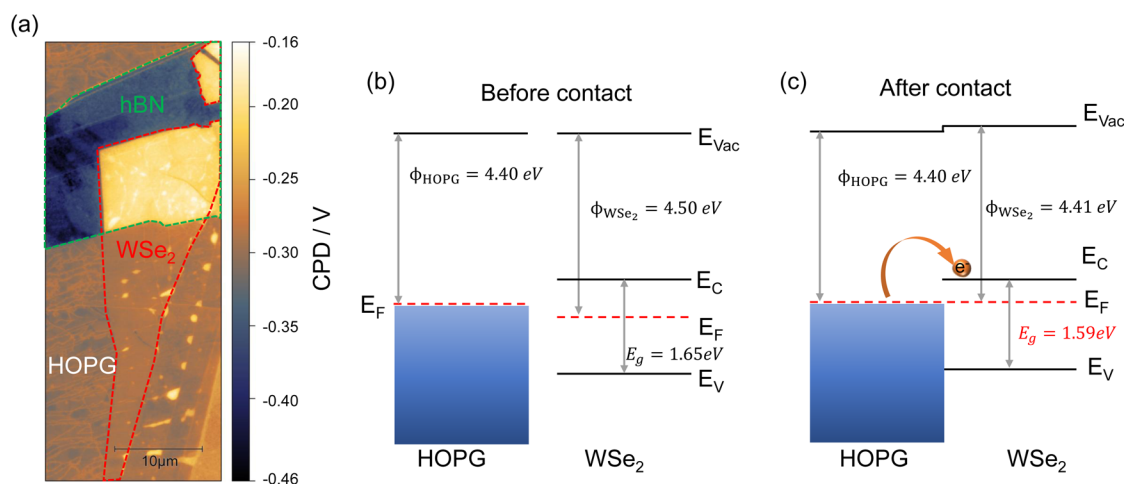


Fig. 3 (a) KPFM of WSe<sub>2</sub>/hBN/HOPG. Band diagram of monolayer WSe<sub>2</sub> and HOPG before (b) and after (c) contact. Before contact means when WSe<sub>2</sub> is isolated from HOPG by hBN and after contact means that WSe<sub>2</sub> is on HOPG.

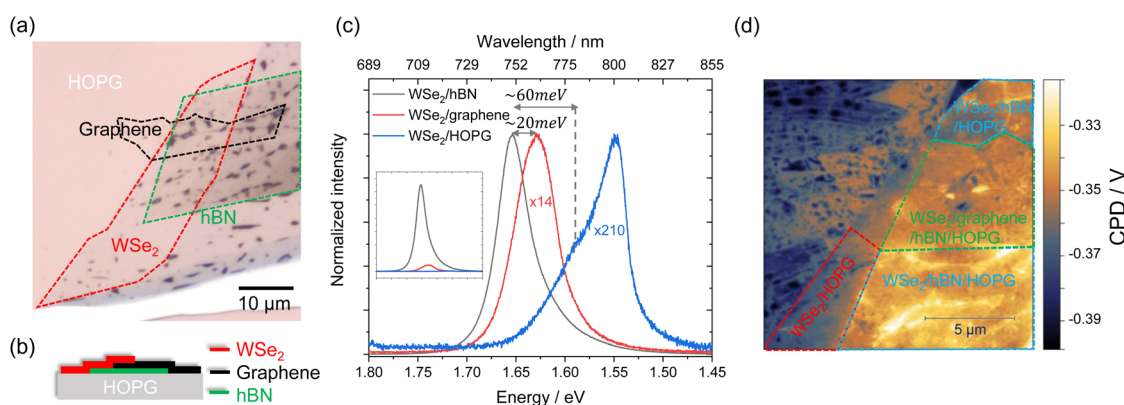


Fig. 4 (a) Optical microscopy image and (b) schematic cross-section of the WSe<sub>2</sub>/graphene/hBN/HOPG hetero-stack. (c) PL spectra of WSe<sub>2</sub>/hBN, WSe<sub>2</sub>/graphene, and WSe<sub>2</sub>/HOPG. For comparison, the intensities of the WSe<sub>2</sub>/graphene and WSe<sub>2</sub>/HOPG PL are normalized to that of WSe<sub>2</sub>/hBN/HOPG. Inset: as-measured (not-normalized) PL spectra. (d) KPFM of WSe<sub>2</sub>/graphene/hBN/HOPG.





as shown in Fig. 4(a) and (b), where WSe<sub>2</sub> is partially on hBN, partially on graphene, and partially on HOPG. The PL spectra of WSe<sub>2</sub>/hBN, WSe<sub>2</sub>/graphene, and WSe<sub>2</sub>/HOPG are shown in Fig. 4(c). Again, we observe a similar PL quenching, redshift, and increasing intensity ratio of trions to neutral excitons for WSe<sub>2</sub> on HOPG. However, a redshift of only 20 meV is detected on WSe<sub>2</sub>/graphene, which is in excellent agreement with the value reported by Raja *et al.*<sup>18</sup> This redshift of the A exciton is attributed to the altered local dielectric screening of the Coulomb interaction in WSe<sub>2</sub>. Besides the 20 meV redshift, there is a clear broadening of the PL for WSe<sub>2</sub> on graphene compared with that of WSe<sub>2</sub> on hBN. We consider that this broadening originates from the environmental dielectric disorder introduced by the several stamping steps during the sample preparation or the charge transfer between WSe<sub>2</sub> and graphene.<sup>62,63</sup> A higher trion emission intensity is also not observed in the case of WSe<sub>2</sub>/graphene. This clearly indicates that the interaction of WSe<sub>2</sub> on graphene is different from that of WSe<sub>2</sub> on HOPG. We assume that this difference is due to the lower amount of free electrons in graphene than that in HOPG. The KPFM measurement performed on such a sample is displayed in Fig. 4(d). A CPD contrast is only observed between WSe<sub>2</sub>/HOPG and WSe<sub>2</sub>/hBN with a value of  $\Delta\text{CPD}_{\text{WSe}_2/\text{hBN}-\text{WSe}_2/\text{HOPG}} = (20.4 \pm 4.9)$  mV, while WSe<sub>2</sub>/graphene and WSe<sub>2</sub>/hBN reveal a negligible difference of  $\Delta\text{CPD}_{\text{WSe}_2/\text{hBN}-\text{WSe}_2/\text{gr}} = (2.4 \pm 4.3)$  mV. This suggests that a significant change of the Fermi level position occurs due to electron doping from the substrate and only happens for WSe<sub>2</sub> on HOPG but not for WSe<sub>2</sub> on graphene. We use the mass action model to estimate the carrier concentration in the monolayers (details in the ESI†).<sup>64,65</sup> Assuming that the radiative decay rates of excitons and trions are in the same order of magnitude as described in ref. <sup>64</sup>, the electron concentration is in the range of  $\sim 10^{13}$  cm<sup>-2</sup> in monolayer WSe<sub>2</sub> interfaced with HOPG, while it is approximately one magnitude smaller when interfaced with hBN or graphene.

## 4 Conclusions

In summary, we investigated WSe<sub>2</sub>/hBN, WSe<sub>2</sub>/graphene, and WSe<sub>2</sub>/HOPG hetero-stacks. We observed a strong PL intensity quenching, 62 meV redshift of the A exciton, and a drastic increase of the intensity ratio of trions to neutral excitons on WSe<sub>2</sub>/HOPG compared to WSe<sub>2</sub>/graphene and WSe<sub>2</sub>/hBN. The KPFM results reveal a high CPD contrast, which indicates a renormalization of the energy level alignment at the interface. The effects observed for WSe<sub>2</sub> on HOPG are thus assigned to significant electron doping of the WSe<sub>2</sub> monolayer from the HOPG substrate. We propose a simple yet efficient way to tune the exciton emission in monolayer WSe<sub>2</sub> by substrate induced electron doping.

## Author contributions

Y. P. fabricated the samples, performed the measurements and analyzed the data. M. R., I. M. L. H., and T. I. M. contributed to data analysis and discussion. G. M., T. B. and A. W. performed the reflectance contrast measurement. M. A. A. and A. M.

provided the graphene. D. R. T. Z. supervised the work. M. R. and D. R. T. Z. were involved in the evaluation and interpretation of the results. Y. P. wrote the manuscript. All authors discussed the results and commented on the manuscript.

## Conflicts of interest

The authors declare no conflict of interest.

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## References

- 1 K. S. Novoselov, *et al.*, Electric field effect in atomically thin carbon films, *Science*, 2004, **306**, 666–669.
- 2 J. A. Wilson and A. Yoffe, The transition metal dichalcogenides discussion and interpretation of the observed optical, electrical and structural properties, *Adv. Phys.*, 1969, **18**, 193–335.
- 3 S. Wu, *et al.*, Vapor–solid growth of high optical quality MoS<sub>2</sub> monolayers with near-unity valley polarization, *ACS Nano*, 2013, **7**, 2768–2772.
- 4 N. Peimyoo, *et al.*, Thermal conductivity determination of suspended mono- and bilayer WS<sub>2</sub> by Raman spectroscopy, *Nano Res.*, 2015, **8**, 1210–1221.
- 5 Y. Li, *et al.*, Enhancement of exciton emission from multilayer MoS<sub>2</sub> at high temperatures: intervalley transfer versus interlayer decoupling, *Small*, 2017, **13**, 1700157.
- 6 A. Splendiani, *et al.*, Emerging photoluminescence in monolayer MoS<sub>2</sub>, *Nano Lett.*, 2010, **10**, 1271–1275.
- 7 Y. Li, *et al.*, Accurate identification of layer number for few-layer WS<sub>2</sub> and WSe<sub>2</sub> via spectroscopic study, *Nanotechnology*, 2018, **29**, 124001.
- 8 H. Tian, *et al.*, Optoelectronic devices based on two-dimensional transition metal dichalcogenides, *Nano Res.*, 2016, **9**, 1543–1560.
- 9 Z. Cheng, *et al.*, 2D Materials Enabled Next-Generation Integrated Optoelectronics: from Fabrication to Applications, *Adv. Sci.*, 2021, **8**, 2003834.
- 10 C. Zhou, *et al.*, Self-driven WSe<sub>2</sub> photodetectors enabled with asymmetrical van der Waals contact interfaces, *NPJ 2D Mater. Appl.*, 2020, **4**, 1–9.
- 11 L. Lackner, *et al.*, Tunable exciton-polaritons emerging from WS<sub>2</sub> monolayer excitons in a photonic lattice at room temperature, *Nat. Commun.*, 2021, **12**, 1–6.
- 12 S. Dufferwiel, *et al.*, Exciton–polaritons in van der Waals heterostructures embedded in tunable microcavities, *Nat. Commun.*, 2015, **6**, 1–7.



- 13 T. Lin, *et al.*, Many-body effects in doped WS<sub>2</sub> monolayer quantum disks at room temperature, *NPJ 2D Mater. Appl.*, 2019, **3**, 1–6.
- 14 J. Xiao, *et al.*, Nonlinear optical selection rule based on valley-exciton locking in monolayer WS<sub>2</sub>, *Light Sci. Appl.*, 2015, **4**, e366.
- 15 P. Gong, H. Yu, Y. Wang and W. Yao, Optical selection rules for excitonic Rydberg series in the massive Dirac cones of hexagonal two-dimensional materials, *Phys. Rev. B*, 2017, **95**, 125420.
- 16 B. M. Francis, *et al.*, Two-dimensional Material based Printed Photonics: A Review, *2D Mater.*, 2022, **9**(4), 042003.
- 17 T. Tan, X. Jiang, C. Wang, B. Yao and H. Zhang, 2D material optoelectronics for information functional device applications: status and challenges, *Adv. Sci.*, 2020, **7**, 2000058.
- 18 A. Raja, *et al.*, Coulomb engineering of the bandgap and excitons in two-dimensional materials, *Nat. Commun.*, 2017, **8**, 1–7.
- 19 Y. Gong, *et al.*, Band gap engineering and layer-by-layer mapping of selenium-doped molybdenum disulfide, *Nano Lett.*, 2014, **14**, 442–449.
- 20 H. J. Conley, *et al.*, Bandgap engineering of strained monolayer and bilayer MoS<sub>2</sub>, *Nano Lett.*, 2013, **13**, 3626–3630.
- 21 R. Frisenda, *et al.*, Biaxial strain tuning of the optical properties of single-layer transition metal dichalcogenides, *NPJ 2D Mater. Appl.*, 2017, **1**, 1–7.
- 22 Z. Li, *et al.*, Active light control of the MoS<sub>2</sub> monolayer exciton binding energy, *ACS Nano*, 2015, **9**, 10158–10164.
- 23 P. V. Nguyen, *et al.*, Visualizing electrostatic gating effects in two-dimensional heterostructures, *Nature*, 2019, **572**, 220–223.
- 24 L. Fernández, *et al.*, Renormalization of the band gap in 2D materials through the competition between electromagnetic and four-fermion interactions in large N expansion, *Phys. Rev. D*, 2020, **102**, 016020.
- 25 A. Chaves, *et al.*, Bandgap engineering of two-dimensional semiconductor materials, *NPJ 2D Mater. Appl.*, 2020, **4**, 1–21.
- 26 P. Tonndorf, *et al.*, Photoluminescence emission and Raman response of monolayer MoS<sub>2</sub>, MoSe<sub>2</sub>, and WSe<sub>2</sub>, *Opt. Exp.*, 2013, **21**, 4908–4916.
- 27 J. Xiao, M. Zhao, Y. Wang and X. Zhang, Excitons in atomically thin 2D semiconductors and their applications, *Nanophotonics*, 2017, **6**, 1309–1328.
- 28 W. Liu, *et al.*, Strong exciton–plasmon coupling in MoS<sub>2</sub> coupled with plasmonic lattice, *Nano Lett.*, 2016, **16**, 1262–1269.
- 29 J. S. Ross, *et al.*, Electrically tunable excitonic light-emitting diodes based on monolayer WSe<sub>2</sub> p–n junctions, *Nat. Nanotechnol.*, 2014, **9**, 268–272.
- 30 M. Ferrera, *et al.*, Controlling excitons in the quantum tunneling regime in a hybrid plasmonic/2D semiconductor interface, *Appl. Phys. Rev.*, 2022, **9**, 031401.
- 31 A. Castellanos-Gomez, *et al.*, Deterministic transfer of two-dimensional materials by all-dry viscoelastic stamping, *2D Mater.*, 2014, **1**, 011002.
- 32 Y. Pan, S. Li, M. Rahaman, I. Milekhin and D. R. T. Zahn, Signature of lattice dynamics in twisted 2D homo/hetero-bilayers, *2D Mater.*, 2022, **9**, 045018.
- 33 L. Ding, *et al.*, Understanding interlayer coupling in TMD-HBN heterostructure by Raman spectroscopy, *IEEE Trans. Electron Devices*, 2018, **65**, 4059–4067.
- 34 R. R. Rojas-Lopez, *et al.*, Photoluminescence and charge transfer in the prototypical 2D/3D semiconductor heterostructure MoS<sub>2</sub>/GaAs, *Appl. Phys. Lett.*, 2021, **119**, 233101.
- 35 Y. Hwang, T. Kim and N. Shin, Interlayer Energy Transfer and Photoluminescence Quenching in MoSe<sub>2</sub>/Graphene van der Waals Heterostructures for Optoelectronic Devices, *ACS Appl. Nano Mater.*, 2021, **4**, 12034–12042.
- 36 B. Zheng, *et al.*, WO<sub>3</sub>–WS<sub>2</sub> vertical bilayer heterostructures with high photoluminescence quantum yield, *J. Am. Chem. Soc.*, 2019, **141**, 11754–11758.
- 37 W. Zheng, *et al.*, Defect-induced distinct exciton-exciton interactions in WS<sub>2</sub> monolayers, *Sci. China Mater.*, 2022, **1–9**, 2502–2510.
- 38 D. Purdie, *et al.*, Cleaning interfaces in layered materials heterostructures, *Nat. Commun.*, 2018, **9**, 1–12.
- 39 S. J. Haigh, *et al.*, Cross-sectional imaging of individual layers and buried interfaces of graphene-based heterostructures and superlattices, *Nat. Mater.*, 2012, **11**, 764–767.
- 40 A. V. Tyurnina, *et al.*, Strained bubbles in van der Waals heterostructures as local emitters of photoluminescence with adjustable wavelength, *ACS Photonics*, 2019, **6**, 516–524.
- 41 J. Huang, T. B. Hoang and M. H. Mikkelsen, Probing the origin of excitonic states in monolayer WSe<sub>2</sub>, *Sci. Rep.*, 2016, **6**, 1–7.
- 42 E. Liu, *et al.*, Valley-selective chiral phonon replicas of dark excitons and trions in monolayer WSe<sub>2</sub>, *Phys. Rev. Res.*, 2019, **1**, 032007.
- 43 M. He, *et al.*, Valley phonons and exciton complexes in a monolayer semiconductor, *Nat. Commun.*, 2020, **11**, 1–7.
- 44 Z. Li, T. Wang, S. Miao, Z. Lian and S.-F. Shi, Fine structures of valley-polarized excitonic states in monolayer transitional metal dichalcogenides, *Nanophotonics*, 2020, **9**, 1811–1829.
- 45 Z. Wu, *et al.*, Defects as a factor limiting carrier mobility in WSe<sub>2</sub>: a spectroscopic investigation, *Nano Res.*, 2016, **9**, 3622–3631.
- 46 Z. Wu and Z. Ni, Spectroscopic investigation of defects in two-dimensional materials, *Nanophotonics*, 2017, **6**, 1219–1237.
- 47 X. Luo, *et al.*, Effects of lower symmetry and dimensionality on Raman spectra in two-dimensional WSe<sub>2</sub>, *Phys. Rev. B*, 2013, **88**, 195313.
- 48 W. Zhao, *et al.*, Lattice dynamics in mono- and few-layer sheets of WS<sub>2</sub> and WSe<sub>2</sub>, *Nanoscale*, 2013, **5**, 9677–9683.
- 49 H. Terrones, *et al.*, New first order Raman-active modes in few layered transition metal dichalcogenides, *Sci. Rep.*, 2014, **4**, 1–9.
- 50 E. Del Corro, *et al.*, Excited excitonic states in 1L, 2L, 3L, and bulk WSe<sub>2</sub> observed by resonant Raman spectroscopy, *ACS Nano*, 2014, **8**, 9629–9635.



- 51 A. Dadgar, *et al.*, Strain engineering and Raman spectroscopy of monolayer transition metal dichalcogenides, *Chem. Mater.*, 2018, **30**, 5148–5155.
- 52 S. B. Desai, *et al.*, Strain-induced indirect to direct bandgap transition in multilayer WSe<sub>2</sub>, *Nano Lett.*, 2014, **14**, 4592–4597.
- 53 W. Melitz, J. Shen, A. C. Kummel and S. Lee, Kelvin probe force microscopy and its application, *Surf. Sci. Rep.*, 2011, **66**, 1–27.
- 54 C. E. Giusca, *et al.*, Water affinity to epitaxial graphene: the impact of layer thickness, *Adv. Mater. Interfac.*, 2015, **2**, 1500252.
- 55 H. Jacobs, P. Leuchtmann, O. Homan and A. Stemmer, Resolution and contrast in Kelvin probe force microscopy, *J. Appl. Phys.*, 1998, **84**, 1168–1173.
- 56 S. Barbet, *et al.*, Cross-talk artefacts in Kelvin probe force microscopy imaging: a comprehensive study, *J. Appl. Phys.*, 2014, **115**, 144313.
- 57 H. Jacobs, H. Knapp and A. Stemmer, Practical aspects of Kelvin probe force microscopy, *Rev. Sci. Instrum.*, 1999, **70**, 1756–1760.
- 58 E. G. Castanon, *et al.*, Calibrated Kelvin-probe force microscopy of 2D materials using Pt-coated probes, *J. Phys. Commun.*, 2020, **4**, 095025.
- 59 A. Matkovic, *et al.*, Interfacial band engineering of MoS<sub>2</sub>/gold interfaces using pyrimidine-containing self-assembled monolayers: toward contact-resistance-free bottom-contacts, *Adv. Electron. Mater.*, 2020, **6**, 2000110.
- 60 J. Xiao, Y. Zhang, H. Chen, N. Xu and S. Deng, Enhanced performance of a monolayer MoS<sub>2</sub>/WSe<sub>2</sub> heterojunction as a photoelectrochemical cathode, *Nano-Micro Lett.*, 2018, **10**, 1–9.
- 61 W. Liu, W. Cao, J. Kang and K. Banerjee, High-performance field-effect-transistors on monolayer-WSe<sub>2</sub>, *ECS Trans.*, 2013, **58**, 281.
- 62 A. Raja, *et al.*, Dielectric disorder in two-dimensional materials, *Nat. Nanotechnol.*, 2019, **14**, 832–837.
- 63 X. Xing, *et al.*, Tunable ultrafast electron transfer in WSe<sub>2</sub>-graphene heterostructures enabled by atomic stacking order, *Nanoscale*, 2022, **14**, 7418–7425.
- 64 S. Mouri, Y. Miyauchi and K. Matsuda, Tunable photoluminescence of monolayer MoS<sub>2</sub> via chemical doping, *Nano Lett.*, 2013, **13**, 5944–5948.
- 65 J. S. Ross, *et al.*, Electrical control of neutral and charged excitons in a monolayer semiconductor, *Nat. Commun.*, 2013, **4**, 1–6.

